## Notice of References Cited Application/Control No. O9/675,931 Examiner Hien Tran Applicant(s)/Patent Under Reexamination DIEZ ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,335,077	06-1982	Santiago et al.	422/179
	В	US-5,190,732	03-1993	Maus et al.	422/179
	С	US-5,293,743	03-1994	Usleman et al.	60/299
	D	US-5,419,876	05-1995	Usui et al.	422/177
	Е	US-6,162,403	12-2000	Foster et al.	422/173
	F	US-		·	
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р				, ·	
	Q					
	R					-
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.